

DCR680N85

Phase Control Thyristor

Preliminary Information



DS5935-1.0 September 2008 (LN 26350)

FEATURES

- Double Side Cooling
- High Surge Capability

APPLICATIONS

- Medium Voltage Soft Starts
- High Voltage Power Supplies
- Static Switches

VOLTAGE RATINGS

Part and Ordering Number	Repetitive Peak Voltages V _{DRM} and V _{RRM} V	Conditions
DCR680N85* DCR680N80 DCR680N75 DCR680N70	8500 8000 7500 7000	$\begin{split} T_{vj} &= -40^\circ\!\text{C to } 125^\circ\!\text{C},\\ I_{DRM} &= I_{RRM} = 200\text{mA},\\ V_{DRM}, V_{RRM}t_p &= 10\text{ms},\\ V_{DSM}\&V_{RSM} &= \\ V_{DRM}\&V_{RRM} + 100V\\ respectively \end{split}$

Lower voltage grades available. 8200V @ -40° C, 8500V @ 0° C

ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

DCR680N85

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

KEY PARAMETERS

V_{DRM}	8500V
$I_{T(AV)}$	677A
I _{TSM}	9800A
dV/dt*	1500V/μs
dl/dt	200A/μs

* Higher dV/dt selections available

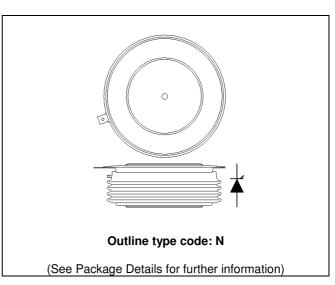


Fig. 1 Package outline



CURRENT RATINGS

T_{case} = 60 °C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Double Si				
I _{T(AV)}	Mean on-state current	Half wave resistive load	677	Α
I _{T(RMS)}	RMS value	-	1063	Α
I _T	Continuous (direct) on-state current	-	1013	Α

SURGE RATINGS

Symbol Parameter		Test Conditions	Max.	Units
I _{TSM}	Surge (non-repetitive) on-state current	10ms half sine, T _{case} = 125 ℃	9.8	kA
I ² t I ² t for fusing		$V_R = 0$	0.48	MA ² s

THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	s	Min.	Max.	Units
R _{th(j-c)}	Thermal resistance – junction to case	Double side cooled	DC	-	0.0221	.c/M
		Single side cooled	Anode DC	-	0.041	.c/M
			Cathode DC	-	0.0516	.c/M
R _{th(c-h)}	Thermal resistance – case to heatsink	Clamping force 23 kN	Double side	-	0.004	.c/M
		(with mounting compound)	Single side	-	0.008	.c/M
T _{vj}	Virtual junction temperature	On-state (conducting)		-	135	°C
		Reverse (blocking)		-	125	.c
T _{stg}	Storage temperature range			-55	125	°C
F _m	Clamping force			20.0	25.0	kN





DYNAMIC CHARACTERISTICS

Symbol	Parameter	Test Conditio	ns	Min.	Max.	Units
I _{RRM} /I _{DRM}	Peak reverse and off-state current	At V _{RRM} /V _{DRM} , T _{case} = 125 ℃		-	200	mA
dV/dt	Max. linear rate of rise of off-state voltage	To 67% V _{DRM} , T _j = 125℃, ga	ate open	-	1500	V/µs
dl/dt	Rate of rise of on-state current	From 67% V _{DRM} to 2x I _{T(AV)}	Repetitive 50Hz	-	100	A/μs
		Gate source 30V, 10Ω,	Non-repetitive	-	200	A/μs
		$t_r < 0.5 \mu s, T_j = 125 ^{\circ}\!\text{C}$				
V _{T(TO)}	Threshold voltage – Low level	100A to 500A at T _{case} = 125°	C	-	1.03	V
	Threshold voltage – High level	500A to 2500A at T _{case} = 125	5℃	-	1.3	V
r _T	On-state slope resistance – Low level	100A to 500A at T _{case} = 125°	rC .	-	2.06	mΩ
	On-state slope resistance – High level	500A to 2500A at T _{case} = 125 ℃		-	1.542	mΩ
t _{gd}	Delay time	$V_D = 67\% V_{DRM}$, gate source	30V, 10Ω	-	3	μs
	,	t _r = 0.5μs, T _j = 25℃				
tq	Turn-off time	$T_j = 125 ^{\circ}\text{C}$, $I_{peak} = 1000 ^{\circ}\text{A}$, $t_p = V_{RM} = 100 ^{\circ}\text{V}$, $dI/dt = -5 ^{\circ}\text{A}/\mu ^{\circ}\text{S}$,	= 1000us,	-	1200	μs
		dV _{DR} /dt = 20V/μs linear to 2500V				
I _{RR}	Reverse recovery current	$I_T = 1000A$, $t_p = 1000us$, $T_i = 125$ °C,		95	118	Α
Qs	Stored charge	$dI/dt = -5A/\mu s$, $V_R = 100V$		3000	4000	μС
IL	Latching current	$T_j = 25$ °C, $V_D = 5$ V		-	3	Α
I _H	Holding current	$T_j = 25$ °C, $R_{G-K} = \infty$, $I_{TM} = 50$	0A, I _T = 5A	-	300	mA



GATE TRIGGER CHARACTERISTICS AND RATINGS

Symbol Parameter		Test Conditions	Max.	Units
V _{GT}	Gate trigger voltage	V _{DRM} = 5V, T _{case} = 25 ℃	1.5	V
V_{GD}	Gate non-trigger voltage	At 50% V _{DRM} , T _{case} = 125 ℃	0.4	V
I _{GT}	Gate trigger current	V _{DRM} = 5V, T _{case} = 25 ℃	250	mA
I _{GD}	Gate non-trigger current	At 50% V _{DRM} , T _{case} = 125 ℃	15	mA

CURVES

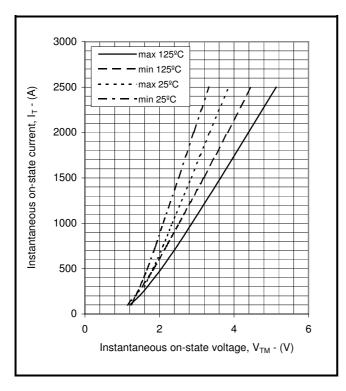


Fig.2 Maximum & minimum on-state characteristics

V_{TM} EQUATION

Where A = 0.454245

 $V_{TM} = A + Bln (I_T) + C.I_T + D.\sqrt{I_T}$

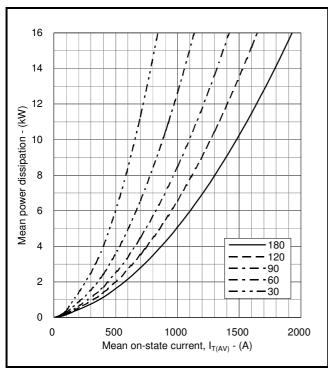
B = 0.106933

C = 0.001271

D = 0.013218

these values are valid for $T_j = 125$ °C for I_T 100A to 3000A







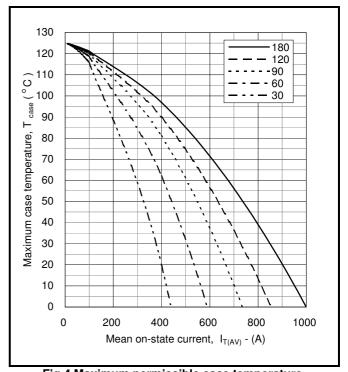


Fig.4 Maximum permissible case temperature, double side cooled – sine wave

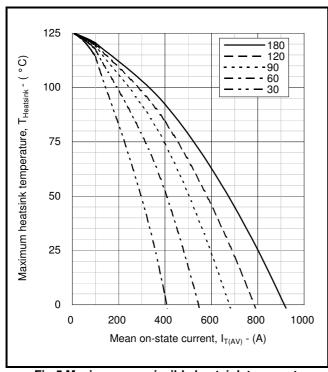


Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave

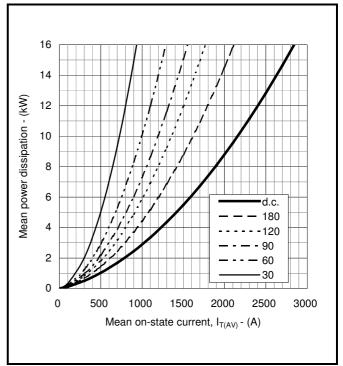


Fig.6 On-state power dissipation - rectangular wave



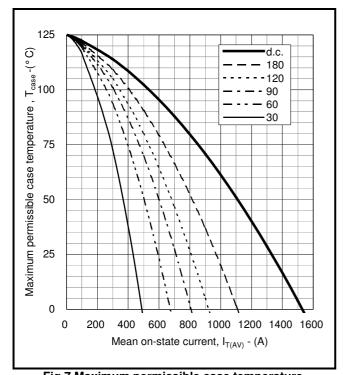


Fig.7 Maximum permissible case temperature, double side cooled – rectangular wave

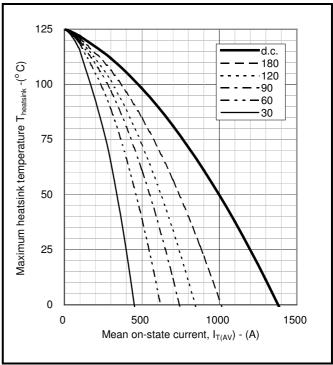
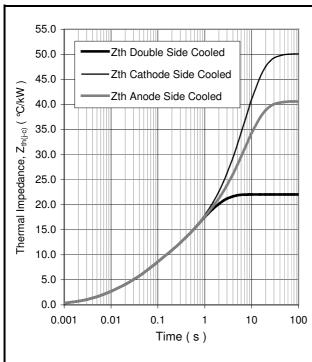


Fig.8 Maximum permissible heatsink temperature, double side cooled – rectangular wave



		1	2	3	4
Double side cooled	R _i (°C/kW)	3.4733	4.9047	9.1463	4.5220
	T _i (s)	0.1457	0.0166	1.2832	0.3767
Anode side cooled	R _i (°C/kW)	7.6674	5.0530	9.7355	27.5992
	T _i (s)	0.2241	0.0169	4.0566	8.2780
Cathode side cooled	R _i (°C/kW)	6.0393	4.2782	5.1301	25.0874
	T _i (s)	0.1356	0.0143	0.6594	7.2358

$$Z_{th} = \sum_{i=1}^{i=4} [R_i \times (1 - \exp(T/T_i))]$$

▲R_{th(j-c)} Conduction

Tables show the increments of thermal resistance $R_{\text{th}(j-c)}$ when the device operates at conduction angles other than d.c.

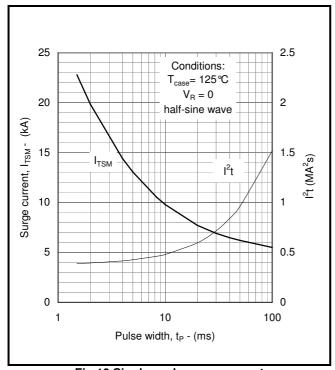
			A		
	ΔZ_{th} (z)				Ī
θ°	sine.	rect.		θ°	Γ
180	3.03	2.07		180	Γ
120	3.49	2.95		120	
90	3.99	3.43		90	Γ
60	4.43	3.94		60	Γ
30	4.77	4.49		30	
1	4 00	4 77		ļ	Г

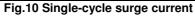
	Anode Side	Anode Side Cooling			
	ΔZ_t	_h (z)			
θ°	sine.	rect.			
180	3.03	2.07			
120	3.49	2.95			
90	3.99	3.43			
60	4.43	3.94			
30	4.76	4.48			
15	4.92	4.77			

Cathode Sided Cooling				
	ΔZ_{t}	_n (z)		
θ°	sine.	rect.		
180	3.12	2.12		
120	3.61	3.04		
90	4.13	3.54		
60	4.60	4.08		
30	4.96	4.66		
15	5.13	4.97		

Fig.9 Maximum (limit) transient thermal impedance – junction to case (°C/kW)







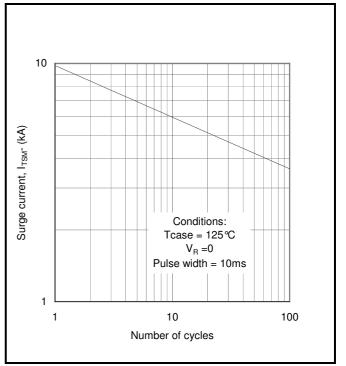


Fig.11 Multi-cycle surge current

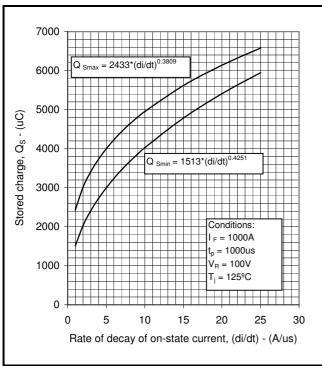


Fig.12 Stored charge

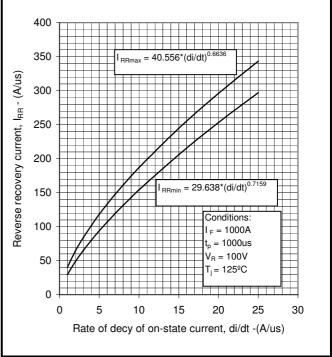


Fig.13 Reverse recovery current

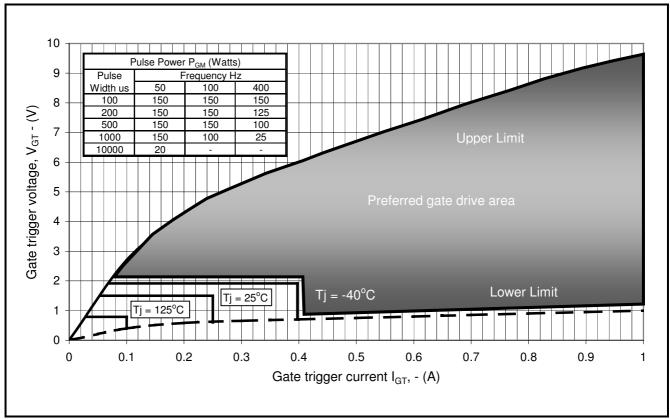


Fig14 Gate Characteristics

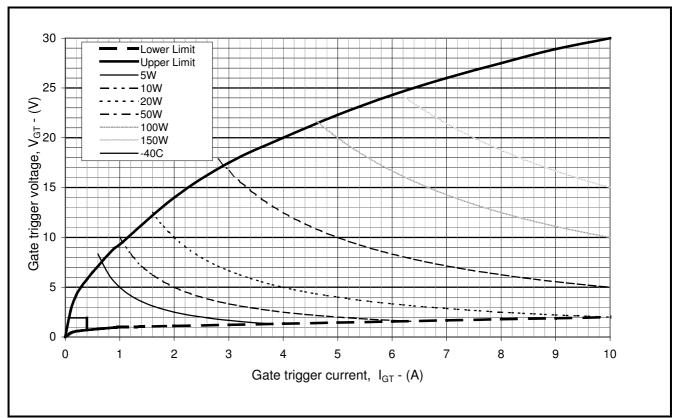


Fig. 15 Gate characteristics

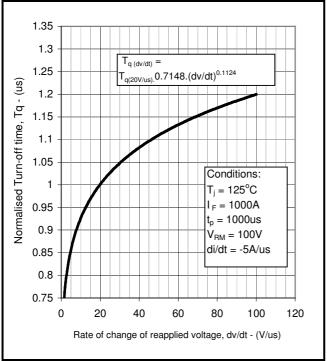


Fig.16 Turn-off time



PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

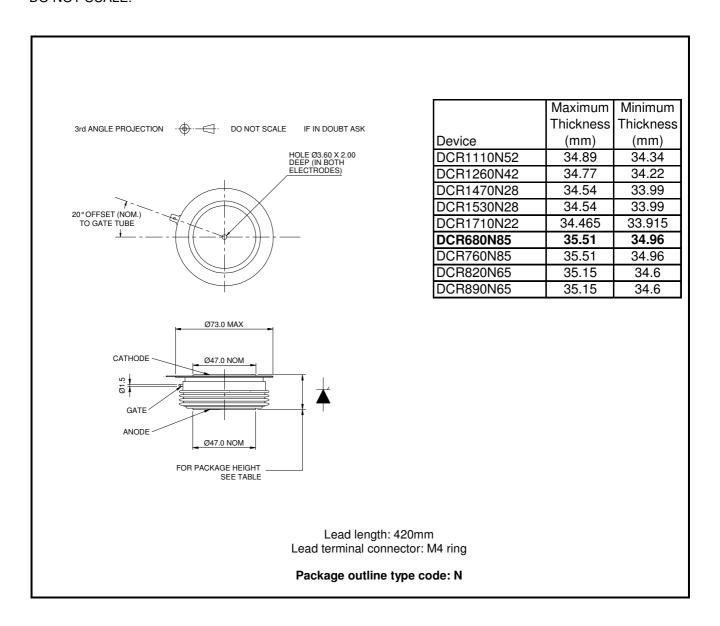


Fig.17 Package outline





POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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